

# **Analog Peripherals**

## 10-Bit ADC

- Programmable throughput up to 200 ksps
- Up to 17 external inputs; programmable as single-ended or differential
- Reference from internal  $V_{\text{REF}},\,V_{\text{DD}},\,\text{or external pin}$
- Internal or external start of conversion sources
- Built-in temperature sensor (±3 °C)

# 10-bit DAC (Current Mode)

### **Two Comparators**

- Programmable hysteresis and response time
- Configurable to generate interrupts or reset
- Low current

## **On-Chip Debug**

- On-chip debug circuitry facilitates full speed, non-intrusive in-system debug (no emulator required)
- Provides breakpoints, single stepping, watchpoints
- Inspect/modify memory, registers, and stack
- Superior performance to emulation systems using ICE-chips, target pods, and sockets

#### Supply Voltage: 2.7 to 3.6 V

## Temperature Range: -40 to +85 °C

## High-Speed 8051 µC Core

 Pipelined instruction architecture; executes 70% of instructions in 1 or 2 system clocks

051F360

- Up to 100 MIPS throughput with 100 MHz system clock
- 16 x 16 multiply/accumulate engine (2-cycle)

#### Memory

- 1280 bytes data RAM with external memory I/F
- 32 kB Flash; in-system programmable in 512 byte sectors (512 bytes are reserved)

# **Digital Peripherals**

- 39 port I/O; all are 5 V tolerant
- Hardware SMBus™ (I2C™ compatible), SPI™, and UART serial ports available concurrently
- Programmable 16-bit counter/timer array with six capture/compare modules, WDT
- 4 general-purpose 16-bit counter/timers
- Real-time clock mode using PCA or timer and external clock source

### **Clock Sources**

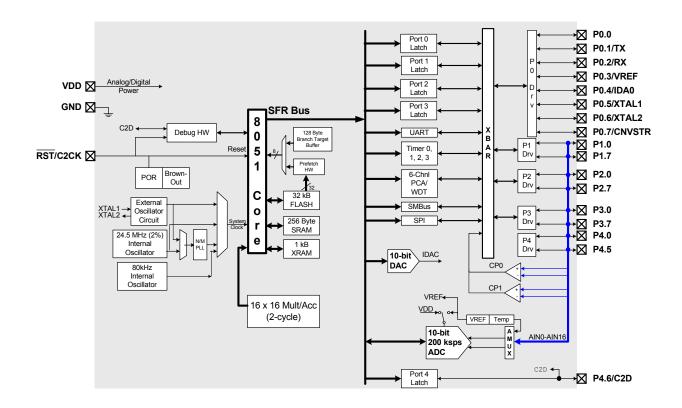
- Two internal oscillators:
  - 24.5 MHz, 2% accuracy supports UART operation
    80 kHz low frequency, low-power
- External oscillator: Crystal, RC, C, or Clock (1 or 2 pin modes)
- On-Chip programmable PLL: up to 100 MHz

## Package

- 48-pin TQFP

## **Ordering Part Number**

- C8051F360-GQ



**Small Form Factor** 





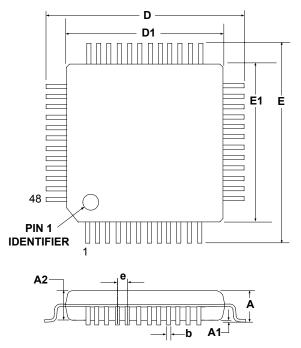
100 MIPS, 16x16 MAC, 32 kB Flash, 10-Bit ADC, Mixed-Signal MCU

# **Selected Electrical Specifications**

(T<sub>A</sub> = -40 to +85 C°, VDD = 2.7 V unless otherwise specified)

Parameter	Conditions	Min	Тур	Max	Units
	Global Characteristics			•	
Supply Voltage		2.7		3.6	V
Supply Current with CPU active	Clock = 100 MHz Clock = 25 MHz Clock = 1 MHz Clock = 10 HHz Clock = 80 kHz; VDD Monitor Disabled Clock = 32 kHz; VDD Monitor Disabled		TBD TBD TBD TBD	   	mA mA μA μA
Supply Current (shutdown)	Oscillator off; V <sub>DD</sub> Monitor Disabled	_	<0.1	—	μA
Clock Frequency Range		DC	_	100	MHz
	Internal Oscillators		1		·
Frequency (OSC0)		24.0	24.5	25.0	MHz
Frequency (OSC1)	OSC1 can be calibrated in 2.5% steps using an internal calibration register.	_	80	_	kHz
	A/D Converter				
Resolution			10		bits
Integral Nonlinearity		TBD	±0.5	TBD	LSB
Differential Nonlinearity	Guaranteed Monotonic	TBD	±0.5	TBD	LSB
Signal-to-Noise Plus Distortion	n	TBD	TBD	—	dB
Throughput Rate		_	—	200	ksps
Input Voltage Range		0	—	V <sub>REF</sub>	V
	D/A Converter				
Resolution		10		bits	
Integral Nonlinearity		—	±0.5	TBD	LSB
Differential Nonlinearity	Guaranteed Monotonic	_	±0.5	TBD	LSB
Output Settling Time		-	5	—	μs
	Comparator				
Response Time Mode0	(CP+) – (CP-) = 100 mV	_	100	_	ns
Current Consumption Mode0		_	TBD	_	μA
Response Time Mode1	(CP+) – (CP-) = 100 mV	-	175	—	ns
Current Consumption Mode1		_	TBD	_	μA
Response Time Mode2	(CP+) – (CP-) = 100 mV	—	320	—	ns
Current Consumption Mode2		—	TBD	—	μA
Response Time Mode3	(CP+) – (CP-) = 100 mV	—	1050	—	ns
Current Consumption Mode3		-	TBD	_	μA

# **Package Information**



# C8051F360DK Development Kit



**Small Form Factor** 

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